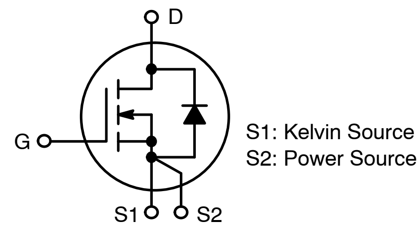
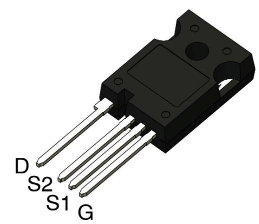
Silicon Carbide (SiC) MOSFET - EliteSiC, 23 mohm, 650 V, M3S, TO-247-4L

NTH4L023N065M3S

$V_{(BR)DSS}$	$R_{DS(ON)}$ TYP	I_D MAX
650 V	23 mΩ @ 18 V	67 A



N-CHANNEL MOSFET



TO-247-4L
CASE 340CJ

Features

- Typical $R_{DS(on)}$ = 23 mΩ @ V_{GS} = 18 V
- Ultra Low Gate Charge ($Q_{G(tot)}$ = 69 nC)
- High Speed Switching with Low Capacitance (C_{oss} = 153 pF)
- 100% Avalanche Tested
- This Device is Halide Free and RoHS Compliant with Exemption 7a, Pb−Free 2LI (on second level interconnection)

Applications

- SMPS, Solar Inverters, UPS, Energy Storages, EV Charging Infrastructure

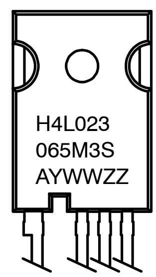
MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter		Symbol	Value	Unit
Drain−to−Source Voltage		V_{DSS}	650	V
Gate−to−Source Voltage		V_{GS}	−8/+22	V
Continuous Drain Current	T_C = 25°C	I_D	67	A
Power Dissipation		P_D	245	W
Continuous Drain Current	T_C = 100°C	I_D	47	A
Power Dissipation		P_D	122	W
Pulsed Drain Current (Note 1)	T_C = 25°C t_p = 100 μs	I_{DM}	225	A
Continuous Source−Drain Current (Body Diode)	T_C = 25°C V_{GS} = −3 V	I_S	37	A
	T_C = 100°C V_{GS} = −3 V		23	
Pulsed Source−Drain Current (Body Diode) (Note 1)	T_C = 25°C V_{GS} = −3 V t_p = 100 μs	I_{SM}	188	A
Single Pulse Avalanche Energy (Note 2)	I_{LPK} = 19.6 A, L = 1 mH	E_{AS}	192	mJ
Operating Junction and Storage Temperature Range		T_J, T_{stg}	−55 to +175	°C
Lead Temperature for Soldering Purposes (1/8″ from case for 10 seconds)		T_L	270	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Single pulse, limited by max junction temperature.
2. E_{AS} of 192 mJ is based on starting T_J = 25°C, L = 1 mH, I_{AS} = 19.6 A, V_{DD} = 100 V, V_{GS} = 18 V.

MARKING DIAGRAM



H4L023065M3S = Specific Device Code
A = Assembly Location
Y = Year
WW = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

Device	Package	Shipping
NTH4L023N065M3S	TO−247−4L	30 Units / Tube

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction−to−Case (Note 3)	$R_{\theta JC}$	0.61	°C/W
Thermal Resistance, Junction−to−Ambient (Note 3)	$R_{\theta JA}$	40	

3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

RECOMMENDED OPERATING CONDITIONS

Parameter	Symbol	Value	Unit
Operation Values of Gate−to−Source Voltage	V_{GSop}	−5...−3 +18	V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
Drain−to−Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS} = 0 V, I_D = 1 mA, T_J = 25°C	650	–	–	V
Drain−to−Source Breakdown Voltage Temperature Coefficient	$\Delta V_{(BR)DSS}/\Delta T_J$	I_D = 1 mA, Referenced to 25°C	–	89	–	mV/°C
Zero Gate Voltage Drain Current	I_{DSS}	V_{DS} = 650 V, T_J = 25°C	–	–	10	μA
		V_{DS} = 650 V, T_J = 175°C (Note 5)	–	–	500	μA
Gate−to−Source Leakage Current	I_{GSS}	V_{GS} = −8/+22 V, V_{DS} = 0 V	–	–	±1.0	μA
ON CHARACTERISTICS						
Drain−to−Source On Resistance	$R_{DS(on)}$	V_{GS} = 18 V, I_D = 20 A, T_J = 25°C	–	23	33	mΩ
		V_{GS} = 18 V, I_D = 20 A, T_J = 175°C (Note 5)	–	34	–	
		V_{GS} = 15 V, I_D = 20 A, T_J = 25°C	–	29	–	
		V_{GS} = 15 V, I_D = 20 A, T_J = 175°C (Note 5)	–	37	–	
Gate Threshold Voltage	$V_{GS(TH)}$	V_{GS} = V_{DS}, I_D = 10 mA, T_J = 25°C	2	2.8	4	V
Forward Transconductance	g_{FS}	V_{DS} = 10 V, I_D = 20 A (Note 5)	–	14	–	S
CHARGES, CAPACITANCES & GATE RESISTANCE						
Input Capacitance	C_{ISS}	V_{DS} = 400 V, V_{GS} = 0 V, f = 1 MHz (Note 5)	–	1952	–	pF
Output Capacitance	C_{OSS}		–	153	–	
Reverse Transfer Capacitance	C_{RSS}		–	13	–	
Total Gate Charge	$Q_{G(TOT)}$	V_{DD} = 400 V, I_D = 20 A, V_{GS} = −3/18 V (Note 5)	–	69	–	nC
Gate−to−Source Charge	Q_{GS}		–	19	–	
Gate−to−Drain Charge	Q_{GD}		–	18	–	
Gate Resistance	R_G	f = 1 MHz	–	4.0	–	Ω
SWITCHING CHARACTERISTICS						
Turn−On Delay Time	$t_{d(ON)}$	V_{GS} = −3/18 V, V_{DD} = 400 V, I_D = 20 A, R_G = 4.7 Ω, T_J = 25°C (Notes 4 and 5)	–	11	–	ns
Turn−Off Delay Time	$t_{d(OFF)}$		–	35	–	
Rise Time	t_r		–	15	–	
Fall Time	t_f		–	9.6	–	
Turn−On Switching Loss	E_{ON}		–	51	–	μJ
Turn−Off Switching Loss	E_{OFF}		–	29	–	
Total Switching Loss	E_{TOT}		–	80	–	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified) (continued)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
SWITCHING CHARACTERISTICS						
Turn−On Delay Time	$t_{d(ON)}$	V_{GS} = −3/18 V, V_{DD} = 400 V, I_D = 20 A, R_G = 4.7 Ω, T_J = 175°C (Notes 4 and 5)	–	9.6	–	ns
Turn−Off Delay Time	$t_{d(OFF)}$		–	41	–	
Rise Time	t_r		–	14	–	
Fall Time	t_f		–	12	–	
Turn−On Switching Loss	E_{ON}		–	51	–	μJ
Turn−Off Switching Loss	E_{OFF}		–	45	–	
Total Switching Loss	E_{TOT}		–	96	–	
SOURCE−TO−DRAIN DIODE CHARACTERISTICS						
Forward Diode Voltage	V_{SD}	I_{SD} = 20 A, V_{GS} = −3 V, T_J = 25°C	–	4.5	6.0	V
		I_{SD} = 20 A, V_{GS} = −3 V, T_J = 175°C (Note 5)	–	4.2	–	
Reverse Recovery Time	t_{RR}	V_{GS} = −3 V, I_S = 20 A, dI/dt = 1000 A/μs, V_{DS} = 400 V, T_J = 25°C (Note 5)	–	19	–	ns
Charge Time	t_a		–	11	–	
Discharge Time	t_b		–	8	–	
Reverse Recovery Charge	Q_{RR}		–	97	–	nC
Reverse Recovery Energy	E_{REC}		–	8.7	–	μJ
Peak Reverse Recovery Current	I_{RRM}		–	11	–	A

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. EON/EOFF result is with body diode.
5. Defined by design, not subject to production test.

TYPICAL CHARACTERISTICS

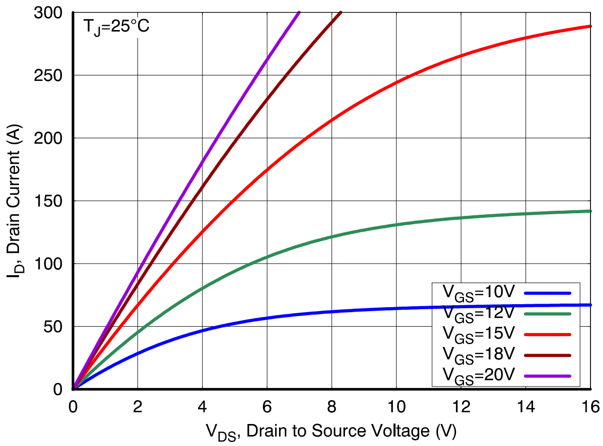


Figure 1. Output Characteristics

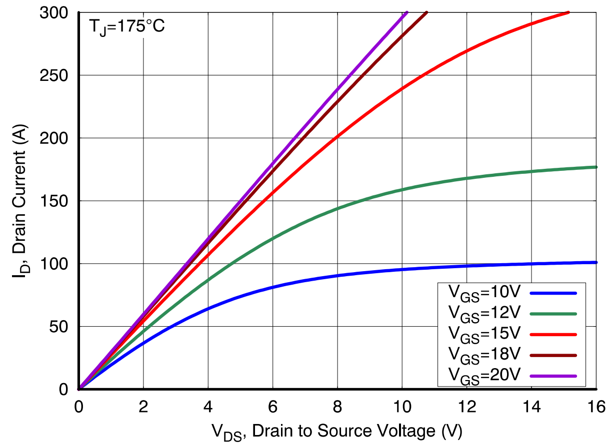


Figure 2. Output Characteristics

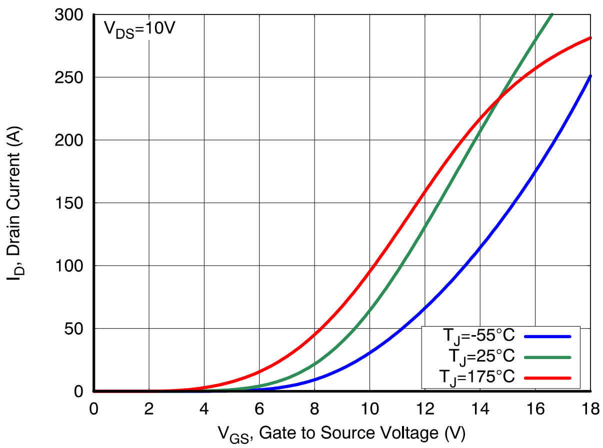


Figure 3. Transfer Characteristics

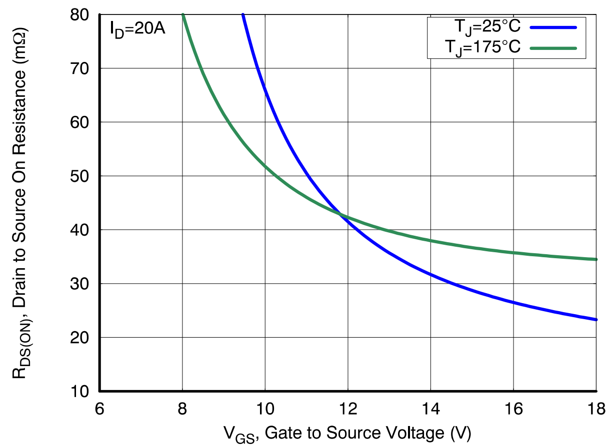


Figure 4. On−Resistance vs Gate Voltage

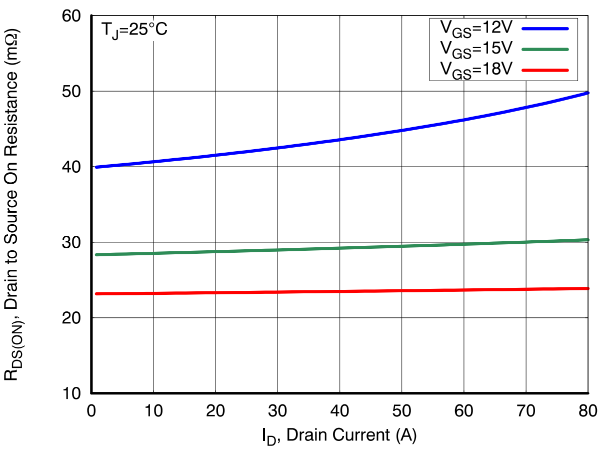


Figure 5. On−Resistance vs Drain Current

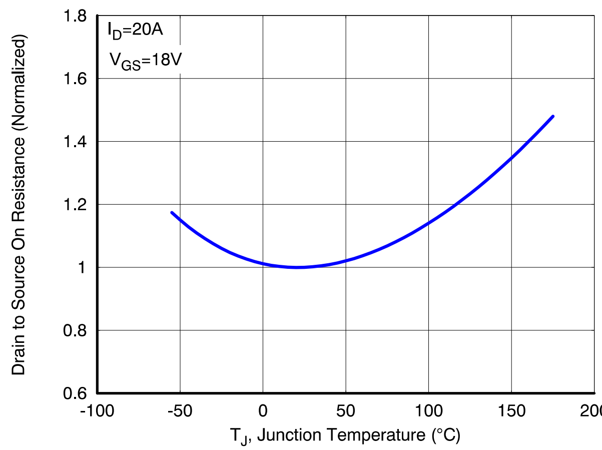


Figure 6. On−Resistance vs Junction Temperature

TYPICAL CHARACTERISTICS

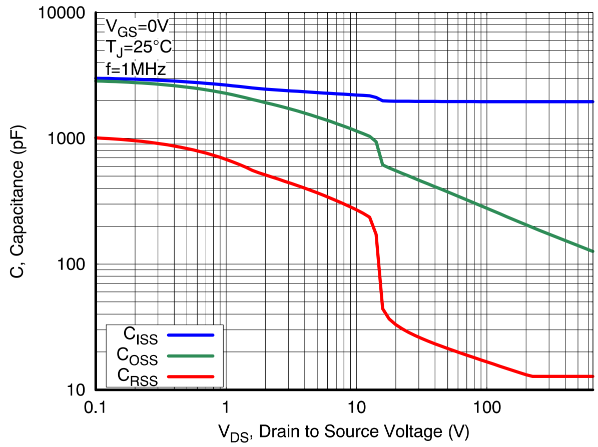


Figure 7. Capacitance Characteristics

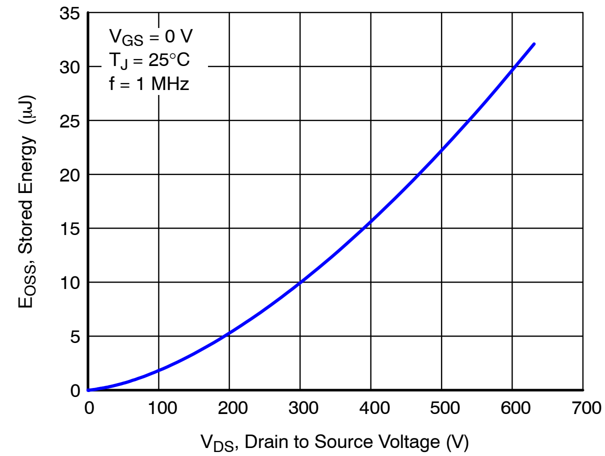


Figure 8. Stored Energy vs Drain to Source Voltage

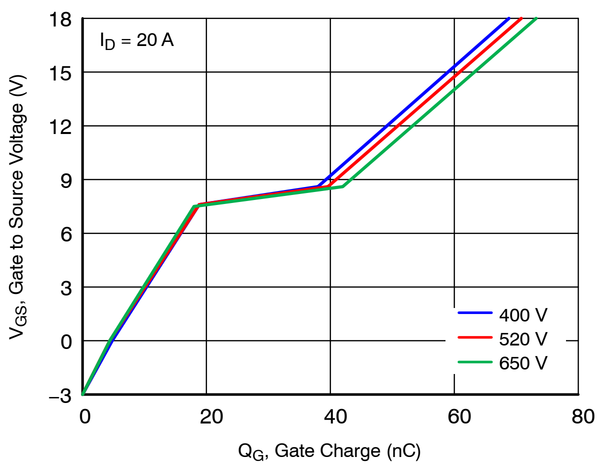


Figure 9. Gate Charge Characteristics

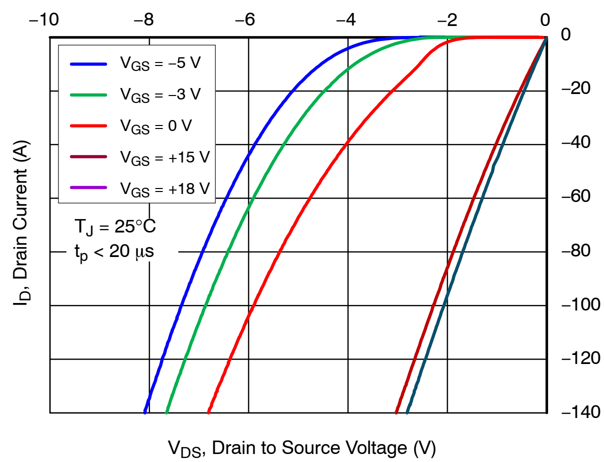


Figure 10. Reverse Conduction Characteristics

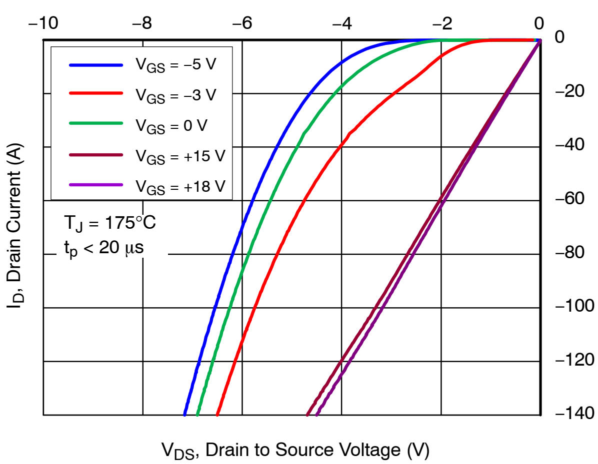


Figure 11. Reverse Conduction Characteristics

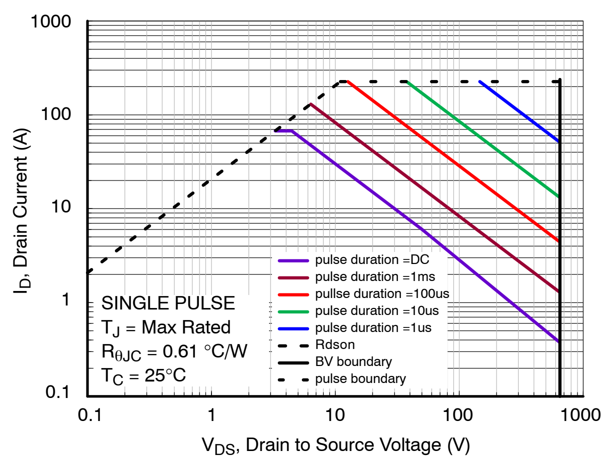


Figure 12. Safe Operating Area

TYPICAL CHARACTERISTICS

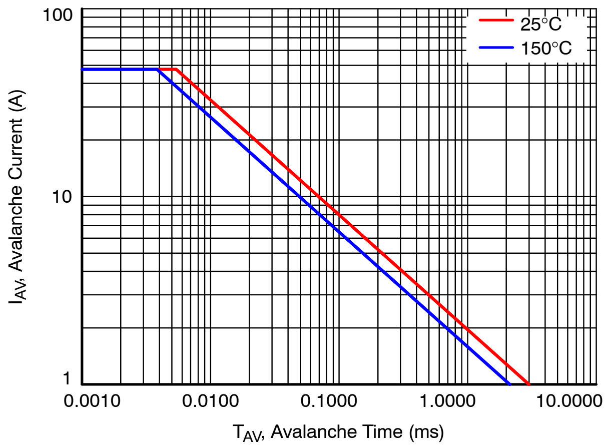


Figure 13. Avalanche Current vs Pulse Time (UIS)

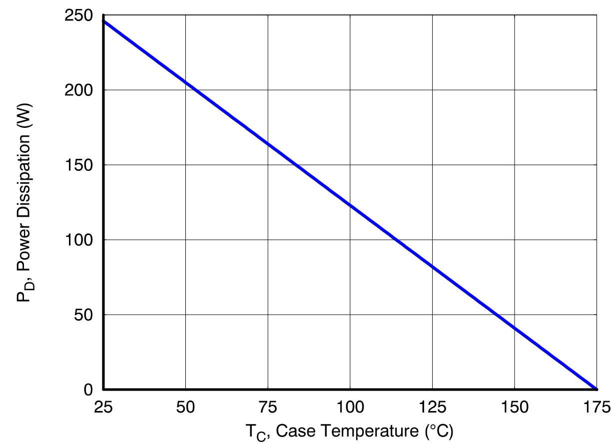


Figure 14. Maximum Power Dissipation vs Case Temperature

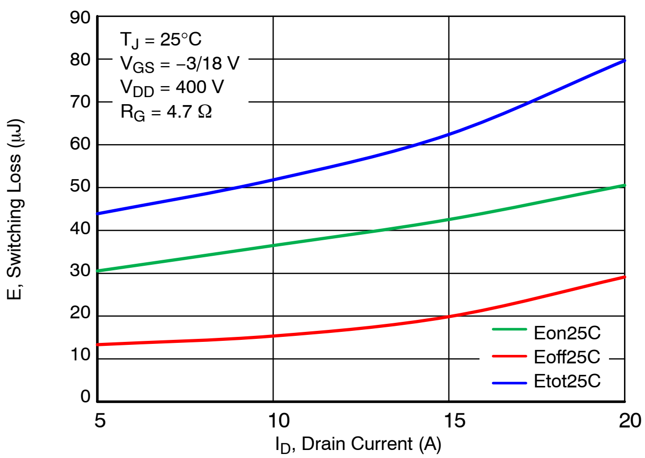


Figure 15. Inductive Switching Loss vs Drain Current

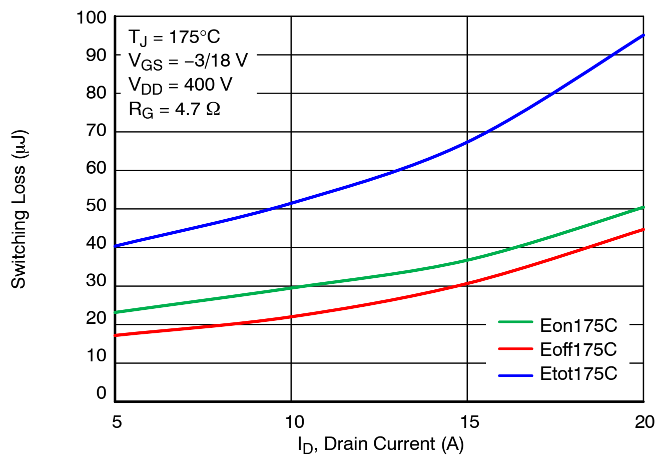


Figure 16. Inductive Switching Loss vs Drain Current

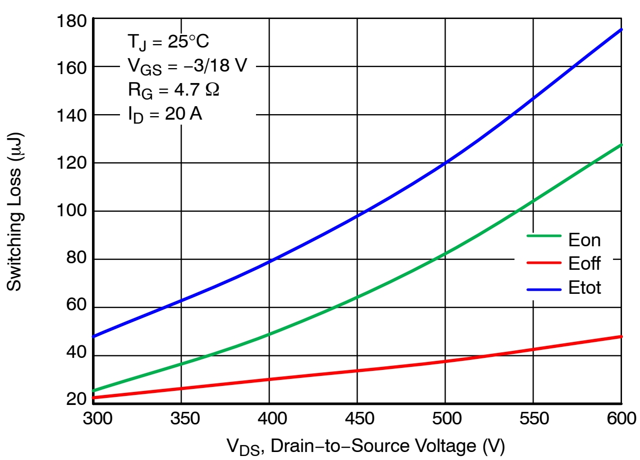


Figure 17. Inductive Switching Loss vs Drain Voltage

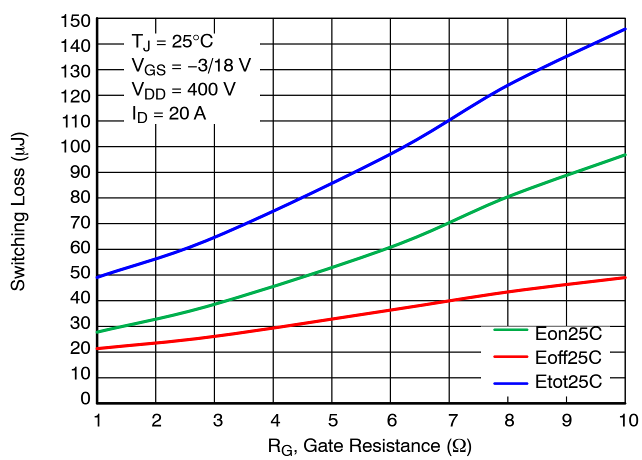


Figure 18. Inductive Switching Loss vs Gate Resistance

TYPICAL CHARACTERISTICS

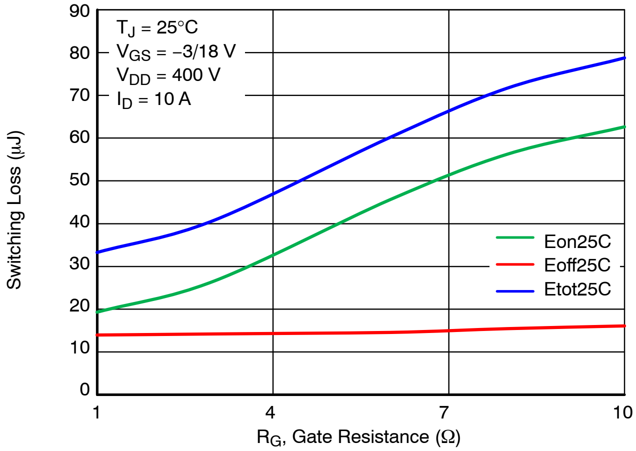


Figure 19. Inductive Switching Loss vs Gate Resistance

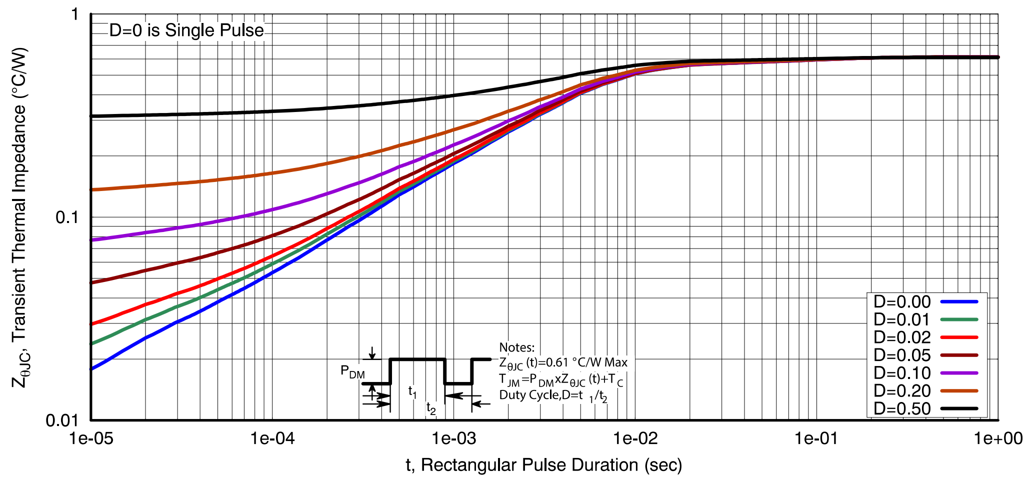
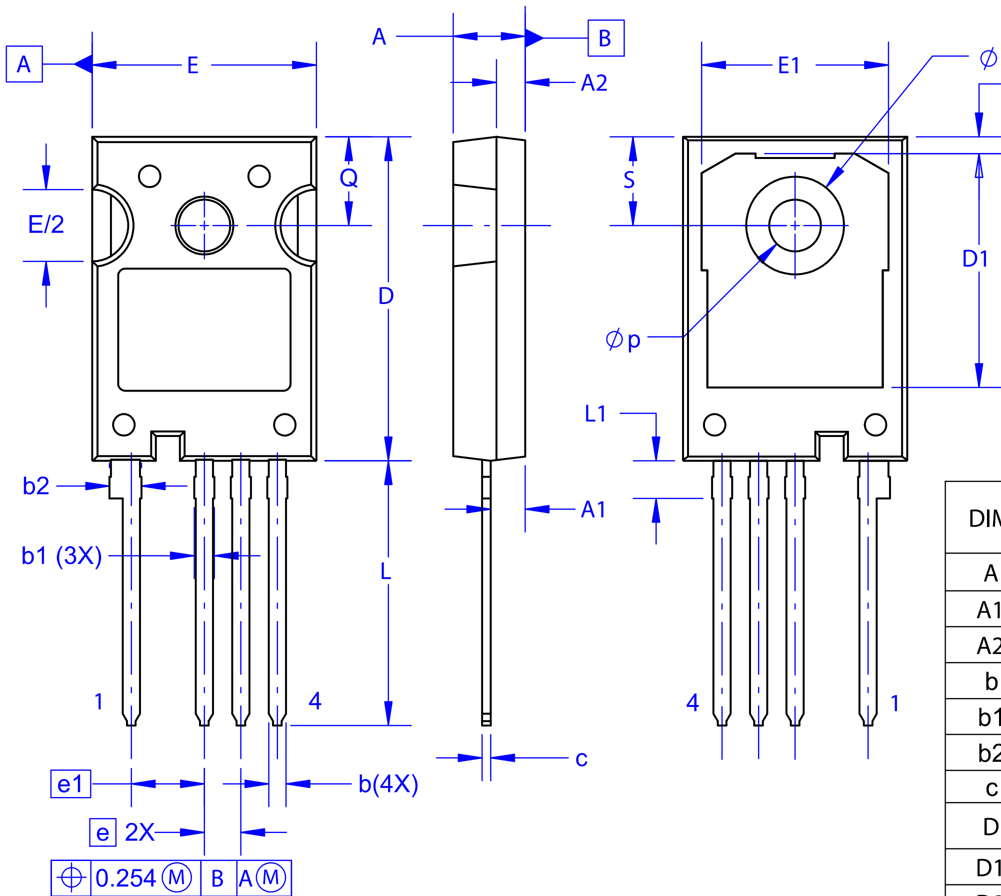


Figure 20. Thermal Response Characteristics

TO−247−4LD
CASE 340CJ
ISSUE A

DATE 16 SEP 2019



DIM	MILLIMETERS		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.10	2.40	2.70
A2	1.80	2.00	2.20
b	1.07	1.20	1.33
b1	1.20	1.40	1.60
b2	2.02	2.22	2.42
c	0.50	0.60	0.70
D	22.34	22.54	22.74
D1	16.00	16.25	16.50
D2	0.97	1.17	1.37
e		2.54 BSC	
e1		5.08 BSC	
E	15.40	15.60	15.80
E1	12.80	13.00	13.20
E/2	4.80	5.00	5.20
L	18.22	18.42	18.62
L1	2.42	2.62	2.82
p	3.40	3.60	3.80
p1	6.60	6.80	7.00
Q	5.97	6.17	6.37
S	5.97	6.17	6.37

NOTES:

A. NO INDUSTRY STANDARD APPLIES TO THIS PACKAGE.
B. DIMENSIONS ARE EXCLUSIVE OF BURRS,MOLD FLASH,AND TIE BAR EXTRUSIONS.
C. ALL DIMENSIONS ARE IN MILLIMETERS.
D. DRAWING CONFORMS TO ASME Y14.5-2009.

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DESCRIPTION:	**TO−247−4LD**	**PAGE 1 OF 1**

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